

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10620697	HAYASHI, KUNIHIKO
<b>Examiner</b>	<b>Art Unit</b>	
Tang, Kenneth	2195	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
718	100, 102-103	8/5/07	KT

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST, text search	8/5/07	KT
Inventor search	8/5/07	KT
NPL Concept search on IP.com based on the Abstract (see search report attached)	8/5/07	KT
IEEE NPL search (see search report attached)	8/5/07	KT
Consulted with QAS on 101	8/6/07	KT
Google Scholar NPL Internet search	1/15/08	KT
Altavista NPL Internet search	1/15/08	KT
EAST, text search	1/15/08	KT
Updated search	6/12/08	KT

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
718	100, 102-103	6/12/08	KT
	PG Pub search	6/12/08	KT